

DS048 (v1.3) October 9, 2000

Features

- Industry's first TotalCMOS[™] SPLD both CMOS design and process technologies
- Fast Zero Power (FZP[™]) design technique provides ultra-low power and high speed
 - Static current of less than 75 μA
 - Dynamic current substantially below that of competing devices
 - Pin-to-pin delay of only 7.5 ns
- True Zero Power device with no turbo bits or power down schemes
- Function/JEDEC map compatible with Bipolar, UVCMOS, EECMOS 22V10s
- Multiple packaging options featuring PCB-friendly flow-through pinouts (SOL and TSSOP)
 - 24-pin TSOIC–uses 93% less in-system space than a 28-pin PLCC
 - 24-pin SOIC
 - 28-pin PLCC with standard JEDEC pinout
- Available in commercial and industrial operating ranges
- Advanced 0.5µ E²CMOS process
- 1000 erase/program cycles guaranteed
- 20 years data retention guaranteed
- Varied product term distribution with up to 16 product terms per output for complex functions
- Programmable output polarity
- Synchronous preset/asynchronous reset capability
- Security bit prevents unauthorized access
- Electronic signature for identification
- Design entry and verification using industry standard CAE tools
- Reprogrammable using industry standard device programmers

XCR22V10: 5V Zero Power, TotalCMOS, Universal PLD Device

Product Specification

Description

The XCR22V10 is the first SPLD to combine high performance with low power, without the need for "turbo bits" or other power down schemes. To achieve this, Xilinx has used their FZP design technique, which replaces conventional sense amplifier methods for implementing product terms (a technique that has been used in PLDs since the bipolar era) with a cascaded chain of pure CMOS gates. This results in the combination of low power and high speed that has previously been unattainable in the PLD arena. For 3V operation, Xilinx offers the XCR22LV10 that offers high speed and low power in a 3V implementation.

The XCR22V10 uses the familiar AND/OR logic array structure, which allows direct implementation of sum-of-products equations. This device has a programmable AND array which drives a fixed OR array. The OR sum of products feeds an "Output Macro Cell" (OMC), which can be individually configured as a dedicated input, a combinatorial output, or a registered output with internal feedback.

Functional Description

The XCR22V10 implements logic functions as sum-of-products expressions in a programmable -AND/fixed-OR logic array. User-defined functions are created by programming the connections of input signals into the array. User-configurable output structures in the form of I/O macrocells further increase logic flexibility (Figure 1).

This product has been discontinued. Please see www.xilinx.com/partinfo/notify/pdn0007.htm for details.

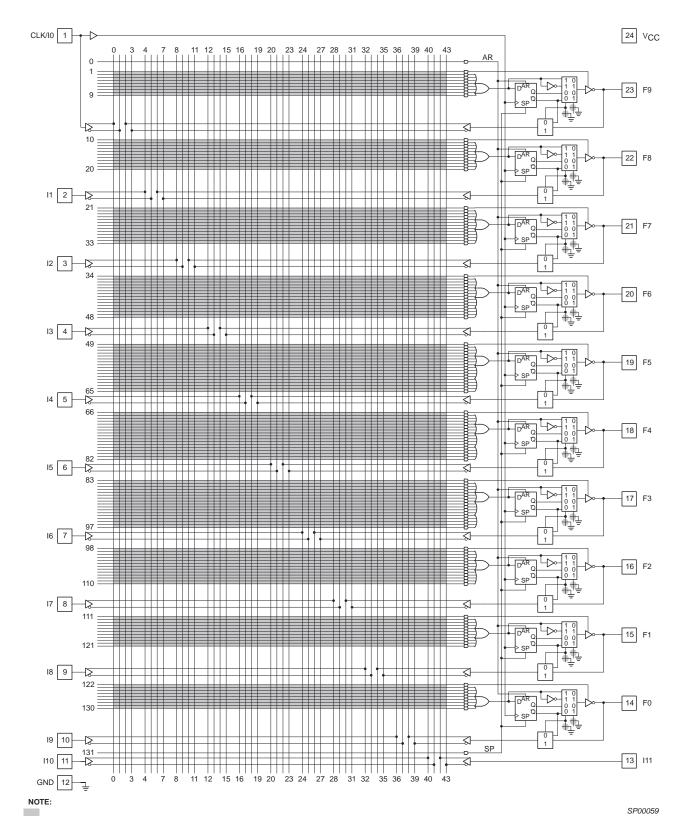


Figure 1: XCR22V10 Logic Diagram

This product has been discontinued. Please see www.xilinx.com/partinfo/notify/pdn0007.htm for details. XCR22V10: 5V Zero Power, TotalCMOS, Universal PLD

Architecture Overview

The XCR22V10 architecture is illustrated in Figure. Twelve dedicated inputs and ten I/Os provide up to 22 inputs and ten outputs for creation of logic functions. At the core of the device is a programmable electrically-erasable AND array which drives a fixed-OR array. With this structure, the XCR22V10 can implement up to ten sum-of-products logic expressions.

Associated with each of the ten OR functions is an I/O macrocell which can be independently programmed to one of four different configurations. The programmable macrocells allow each I/O to create sequential or combinatorial logic functions with either active High or active Low polarity.

AND/OR Logic Array

The programmable AND array of the XCR22V10 (shown in the Logic Diagram, Figure 1) is formed by input lines intersecting product terms. The input lines and product terms are used as follows:

44 input lines:

• 24 input lines carry the True and Complement of the signals applied to the 12 input pins

- 20 additional lines carry the True and Complement values of feedback or input signals from the ten I/Os
- 132 product terms:
- 120 product terms (arranged in two groups of 8, 10, 12, 14, and 16) used to form logical sums
- Ten output enable terms (one for each I/O)
- One global synchronous preset product term
- One global asynchronous clear product term

At each input-line/product-term intersection there is an EEPROM memory cell which determines whether or not there is a logical connection at that intersection. Each product term is essentially a 44-input AND gate. A product term which is connected to both the True and Complement of an input signal will always be FALSE, and thus will not affect the OR function that it drives. When all the connections on a product term are opened, a Don't Care state exists and that term will always be TRUE.

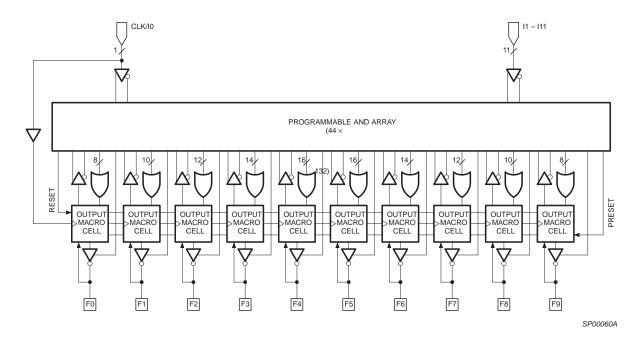


Figure 2: Functional Diagram

Variable Product Term Distribution

The XCR22V10 provides 120 product terms to drive the ten OR functions. These product terms are distributed among the outputs in groups of 8, 10, 12, 14, and 16 to form logical sums (see Logic Diagram). This distribution allows optimum use of device resources.

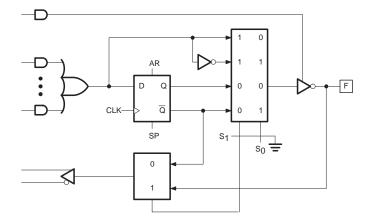
Programmable I/O Macrocell

The output macrocell provides complete control over the architecture of each output. the ability to configure each output independently permits users to tailor the configura-

tion of the XCR22V10 to the precise requirements of their designs.

Macrocell Architecture

Each I/O macrocell, as shown in Figure 3 consists of a D-type flip-flop and two signal-select multiplexers. The configuration of each macrocell of the XCR22V10 is determined by the two EEPROM bits controlling these multiplexers. These bits determine output polarity, and output type (registered or non-registered). Equivalent circuits for the macrocell configurations are illustrated in Figure 4.



S 1	S ₀	OUTPUT CONFIGURATION
0	0	Registered/Active-LOW/Macrocell feedback
0	1	Registered/Active-HIGH/Macrocell feedback
1	0	Combinatorial/Active-LOW/Pin feedback
1	1	Combinatorial/Active-HIGH/Pin feedback

0 = Unprogrammed fuse 1 = Programmed fuse

SP00484

Figure 3: Output Macrocell Logic Diagram

Figure 4: Output Macrocell Configurations



Output Type

The signal from the OR array can be fed directly to the output pin (combinatorial function) or latched in the D-type flip-flop (registered function). The D-type flip-flop latches data on the rising edge of the clock and is controlled by the global preset and clear terms. When the synchronous preset term is satisfied, the Q output of the register will be set High at the next rising edge of the clock input. Satisfying the asynchronous clear term will set Q LOW, regardless of the clock state. If both terms are satisfied simultaneously, the clear will override the preset.

Program/Erase Cycles

The XCR22V10 is 100% testable, erases/programs in seconds, and guarantees 1000 program/erase erase cycles.

Output Polarity

Each macrocell can be configured to implement active High or active Low logic. Programmable polarity eliminates the need for external inverters.

Output Enable

The output of each I/O macrocell can be enabled or disabled under the control of its associated programmable output enable product term. When the logical conditions programmed on the output enable term are satisfied, the output signal is propagated to the I/O pin. Otherwise, the output buffer is driven into the high-impedance state.

Under the control of the output enable term, the I/O pin can function as a dedicated input, a dedicated output, or a bidirectional I/O. Opening every connection on the output enable term will permanently enable the output buffer and yield a dedicated output. Conversely, if every connection is intact, the enable term will always be logically FALSE and the I/O will function as a dedicated input.

Register Feedback Select

When the I/O macrocell is configured to implement a registered function (S1=0) (Figure 4a or Figure 4b), the feedback signal to the AND array is taken from the Q output.

Bi-directional I/O Select

When configuring an I/O macrocell to implement a combinatorial function (S1=1) (Figure 4c or Figure 4d), the feedback signal is taken from the I/O pin. In this case, the pin can be used as a dedicated input, a dedicated output, or a bi-directional I/O.

Power-On Reset

To ease system initialization, all flip-flops will power-up to a reset condition and the Q output will be low. The actual out-

put of the XCR22V10 will depend on the programmed output polarity. The V_{CC} rise must be monotonic.

Design Security

The XCR22V10 provides a special EEPROM security bit that prevents unauthorized reading or copying of designs programmed into the device. The security bit is set by the PLD programmer, either at the conclusion of the programming cycle or as a separate step, after the device has been programmed. Once the security bit is set, it is impossible to verify (read) or program the XCR22V10 until the entire device has first been erased with the bulk-erase function.

TotalCMOS Design Technique for Fast Zero Power

Xilinx is the first to offer a TotalCMOS SPLD, both in process technology and design technique. Xilinx employs a cascade of CMOS gates to implement its Sum of Products instead of the traditional sense amp approach. This CMOS gate implementation allows Xilinx to offer SPLDs which are both high performance and low power, breaking the paradigm that to have low power, you must accept low performance. Refer to Figure 5 and Table 1 showing the I_{CC} vs. Frequency of our XCR22V10 TotalCMOS SPLD.

Table 1: Typical I_{CC} vs. Frequency @ V_{CC} = 5V, 25°C

Frequency (MHz)	Tupical I _{CC} (mA)
1	0.5
10	1.9
20	3.5
30	5.0
40	6.5
50	8.1
60	9.5
70	10.9
80	12.4
90	13.9
100	15.4
110	16.7
120	18.1
130	19.4
140	20.7
150	22.1
160	23.5
170	24.8
180	26.2
190	27.5
200	28.7

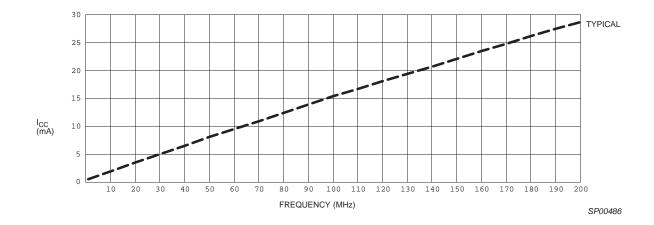


Figure 5: Typical I_{CC} vs. Frequency @ V_{CC} = 5V, 25°C (10-bit counter)

Absolute Maximum Ratings¹

Symbol	Parameter		Max.	Unit
V _{CC}	Supply voltage ²	-0.5	7.0	V
VI	Input voltage	-1.2	V _{CC} +0.5	V
V _{OUT}	Output voltage	-0.5	V _{CC} +0.5	V
I _{IN}	Input current	-30	30	mA
I _{OUT}	Output current		100	mA
T _R	Allowale thermal rise ambient to junction		75	°C
TJ	Maximum junction temperature		150	°C
T _{STG}	Storage temperature		150	°C
ESD	Static discharge voltage (human body)	-	1000	V

Notes:

XILINX[®]

 Stresses above those listed may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification is not implied..

Operating Range

Product Grade	Temperature	Voltage
Commercial	0 to +70°C	5V ± 5%
Industrial	–40 to +85°C	5V ± 10%



DC Electrical Characteristics For Commercial Grade Devices

Commercial: $0^{\circ}C \le T_{AMB} \le +70^{\circ}C$; $4.75V \le V_{CC} \le 5.25V$

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{IL}	Input voltage Low	$V_{CC} = 4.75V$			0.8	V
V _{IH}	Input voltage High	$V_{CC} = 5.25V$	2			V
VI	Input clamp voltage	V _{CC} = 4.75V, I _{IN} = -18 mA			-1.2	V
V _{OL}	Output voltage Low	V _{CC} = 4.75V, I _{OL} = 8 mA			0.5	V
V _{OH}	Output voltage High	$V_{CC} = 4.75 V, I_{OH} = -4 mA$	2.4			V
l _l	Input leakage current	$V_{IN} = 0V$ to V_{CC}	-10		10	μA
I _{OZL}	3-stated output leakage current	$V_{IN} = 0V$ to V_{CC}	-10		10	μA
I _{CCQ}	Standby current	V _{CC} = 5.25V, T _{AMB} = 0°C		60	75	μA
I _{CCD} ¹	Dynamic current	V _{CC} = 5.25V, T _{AMB} = 0°C at 1 MHz		1	3	mA
		V _{CC} = 5.25V, T _{AMB} = 0°C at 50 MHz		10	15	mA
I _{OS}	Short circuit output current	One pin at a time for no longer than 1 second	-30		-100	mA
C _{IN}	Input pin capacitance	$T_{AMB} = 25^{\circ}C, f = 1 MHz$			10	pF
C _{CLK}	Clock input capacitance	$T_{AMB} = 25^{\circ}C, f = 1 MHz$	5		12	pF
C _{I/O}	I/O pin capacitance	$T_{AMB} = 25^{\circ}C, f = 1 MHz$			10	pF

Notes:

1. This parameter measured with a 10-bit, with all outputs enabled and unloaded. Inputs are tied to V_{CC} or ground. This parameter is not 100% tested, but is calculated at initial characterization and at any time the design is modified where current may be affected.

AC Electrical Characteristics For Commercial Grade Devices

Commercial: $0^{\circ}C \le T_{AMB} \le + 70^{\circ}C$; $4.75V \le V_{CC} \le 5.25V$

Deremeter		7		D	
Faiallietei		Max.	Min.	Max.	Unit
Propagation delay time, input or feedback to non-registered output		7.5		10	ns
Setup time from input, feedback or SP to Clock	3		4		ns
Clock to output		6.75		8	ns
Clock to feedback ¹		2		3	ns
Holt time		2		3	ns
Asynchronous Reset to registered output		15		15	ns
Asynchronous Reset width	5		5		ns
Asynchronous Reset recovery time		5		5	ns
Synchronou Preset recovery time		5		5	ns
Width of Clock Low	3		3		μs
Width of Clock High	3		3		μs
Input rise time		20		20	ns
Input fall time		20		20	ns
Maximum FF toggle rate ² (1/t _{SU} + t _{CF})	200		143		MHz
Maximum internal frequency ¹ (1/t _{SU} + t _{CO})	103		83		MHz
Maximum external frequency ¹ (1/t _{WL} + t _{WH})	167		167		MHz
Input to output enable		9		10	ns
Input to output disable		9		10	ns
nce					
Input pin capacitance		10		10	pF
Output capacitance		12		12	pF
	Setup time from input, feedback or SP to ClockClock to outputClock to feedback1Holt timeAsynchronous Reset to registered outputAsynchronous Reset widthAsynchronous Reset recovery timeSynchronou Preset recovery timeWidth of Clock LowWidth of Clock HighInput rise timeInput fall timeMaximum internal frequency1 ($1/t_{SU} + t_{CF}$)Maximum external frequency1 ($1/t_{SU} + t_{WH}$)Input to output disableInput to output disableInput pin capacitance	ParameterMin.Propagation delay time, input or feedback to non-registered outputSetup time from input, feedback or SP to Clock3Clock to outputClock to feedback ¹ Holt timeAsynchronous Reset to registered outputAsynchronous Reset to registered output5Asynchronous Reset width5Asynchronous Reset recovery timeWidth of Clock Low3Width of Clock High3Input rise timeInput fall time200Maximum internal frequency ¹ (1/t _{SU} + t _{CP})103Maximum external frequency ¹ (1/t _{WL} + t _{WH})167Input to output disableInput pin capacitance	ParameterMin.Max.Propagation delay time, input or feedback to non-registered output7.5Setup time from input, feedback or SP to Clock3Clock to output6.75Clock to feedback ¹ 2Holt time2Asynchronous Reset to registered output15Asynchronous Reset to registered output5Asynchronous Reset recovery time5Synchronou Preset recovery time5Width of Clock Low3Width of Clock High3Input rise time20Maximum internal frequency ¹ (1/t _{SU} + t _{CP})200Maximum external frequency ¹ (1/t _{SU} + t _{CO})103Input to output disable9Input to output disable9Input pin capacitance10	ParameterMin.Max.Min.Propagation delay time, input or feedback to non-registered output7.57.5Setup time from input, feedback or SP to Clock34Clock to output6.756.75Clock to feedback ¹ 22Holt time22Asynchronous Reset to registered output155Asynchronous Reset width55Asynchronous Reset recovery time55Width of Clock Low333Width of Clock High333Input rise time20143Maximum internal frequency ¹ (1/t _{SU} + t _{CO})10383Maximum external frequency ¹ (1/t _{WL} + t _{WH})167167Input to output disable99Input pin capacitance1010	ParameterMin.Max.Min.Max.Propagation delay time, input or feedback to non-registered output7.510Setup time from input, feedback or SP to Clock34Clock to output6.758Clock to feedback ¹ 23Holt time23Asynchronous Reset to registered output1515Asynchronous Reset width55Asynchronous Reset recovery time55Synchronou Preset recovery time33Width of Clock Low33Input rise time2020Input fall time2020Maximum internal frequency ¹ (1/t _{SU} + t _{CC})10383Maximum external frequency ¹ (1/t _{WL} + t _{WH})167167Input to output disable91010Input pin capacitance101010

Notes:

1. This parameter is not 100% tested, but is calculated at initial characterization and at any time the design is modified where current may be affected.

2. This parameter measured with a 10-bit, with all outputs enabled and unloaded. Inputs are tied to V_{CC} or ground. This parameter is not 100% tested, but is calculated at initial characterization and at any time the design is modified where current may be affected.



DC Electrical Characteristics For Industrial Grade Devices

Industrial: $-40^{\circ}C \le T_{AMB} \le +85^{\circ}C$; $4.5V \le V_{CC} \le 5.5V$

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{IL}	Input voltage Low	$V_{CC} = 4.75V$			0.8	V
V _{IH}	Input voltage High	$V_{CC} = 5.25V$	2			V
VI	Input clamp voltage	V _{CC} = 4.75V, I _{IN} = -18 mA			-1.2	V
V _{OL}	Output voltage Low	V _{CC} = 4.75V, I _{OL} = 8 mA			0.5	V
V _{OH}	Output voltage High	$V_{CC} = 4.75V, I_{OH} = -4 \text{ mA}$	2.4			V
l _l	Input leakage current	$V_{IN} = 0V$ to V_{CC}	-10		10	μA
I _{OZL}	3-stated output leakage current	$V_{IN} = 0V$ to V_{CC}	-10		10	μA
I _{CCQ}	Standby current	$V_{CC} = 5.25V, T_{AMB} = -40^{\circ}C$		70	95	μA
I _{CCD} ¹	Dynamic current	$V_{CC} = 5.25V$, $T_{AMB} = -40^{\circ}C$ at 1 MHz		1	3	mA
		$V_{CC} = 5.25V$, $T_{AMB} = -40^{\circ}C$ at 50 MHz		10	20	mA
I _{OS}	Short circuit output current	One pin at a time for no longer than 1 second	-30		-100	mA
C _{IN}	Input pin capacitance	$T_{AMB} = 25^{\circ}C$, f = 1 MHz			10	pF
C _{CLK}	Clock input capacitance	$T_{AMB} = 25^{\circ}C$, f = 1 MHz	5		12	pF
C _{I/O}	I/O pin capacitance	$T_{AMB} = 25^{\circ}C$, f = 1 MHz			10	pF

Notes:

1. This parameter measured with a 10-bit, with all outputs enabled and unloaded. Inputs are tied to V_{CC} or ground. This parameter is not 100% tested, but is measured at initial characterization and at any time the design is modified where current may be affected.

AC Electrical Characteristics For Industrial Grade Devices

Industrial: $-40^\circ C \leq T_{AMB} \leq +85^\circ C;~4.5V \leq V_{CC} \leq 5.5V$

Symbol	Deremeter		Unit		
Symbol	Parameter	Min.	Max.	Unit	
t _{PD}	Propagation delay time, input or feedback to non-registered output		10	ns	
t _{SU}	Setup time from input, feedback or SP to Clock	5		ns	
t _{CO}	Clock to output		8.5	ns	
t _{CF}	Clock to feedback ¹		4	ns	
t _H	Holt time		03	ns	
t _{AR}	Asynchronous Reset to registered output		15	ns	
t _{ARW}	Asynchronous Reset width	5		ns	
t _{ARR}	Asynchronous Reset recovery time		5	ns	
t _{SPF}	Synchronou Preset recovery time		5	ns	
t _{WL}	Width of Clock Low	3		ns	
t _{WH}	Width of Clock High	3		ns	
t _R	Input rise time		20	ns	
t _F	Input fall time		20	ns	
f _{MAX1}	Maximum FF toggle rate ² (1/t _{SU} + t _{CF})	111		MHz	
f _{MAX2}	Maximum internal frequency ¹ (1/t _{SU} + t _{CO})	74		MHz	
f _{MAX3}	Maximum external frequency ¹ (1/t _{WL} + t _{WH})	167		MHz	
t _{EA}	Input to output enable		11	ns	
t _{ER}	Input to output disable		11	ns	
Capacita	nce	•		·	
CIN	Input pin capacitance		10	pF	
C _{OUT}	Output capacitance		12	pF	

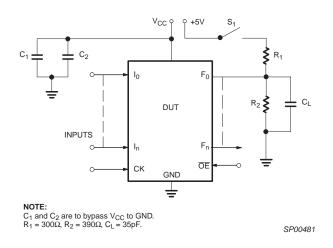
Notes:

1. This parameter is not 100% tested, but is calculated at initial characterization and at any time the design is modified where current may be affected.

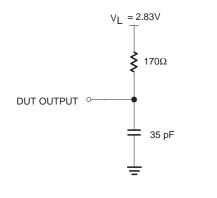
 This parameter measured with a 10-bit, with all outputs enabled and unloaded. Inputs are tied to V_{CC} or ground. This parameter is not 100% tested, but is measured at initial characterization and at any time the design is modified where current may be affected.



Test Load Circuit



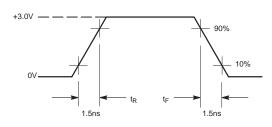
Thevenin Equivalent



SP00482

SP00368

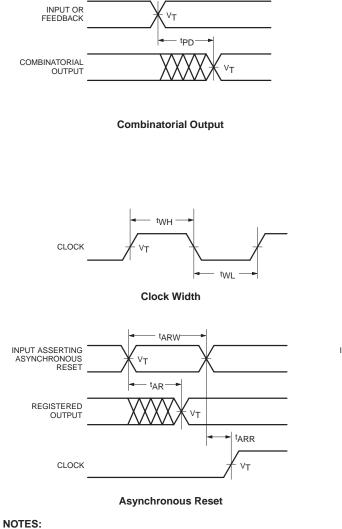
Voltage Waveform

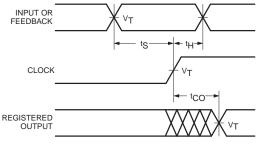


MEASUREMENTS: All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

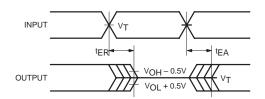
Input Pulses

Switching Waveforms

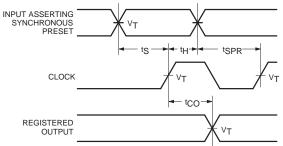




Registered Output



Input to Output Disable/Enable



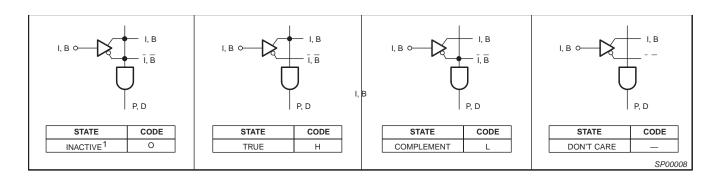
Synchronous Preset

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"AND" Array: (I,B)

Input pulse amplitude 0V to 3.0V.
Input rise and fall times 2.0 ns max.

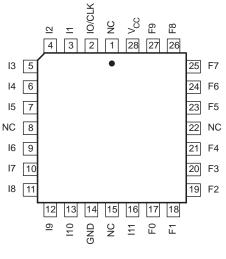
1. $V_T = 1.5V$.





Pin Configurations

28-pin PLCC

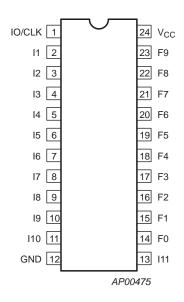


Pin Descriptions

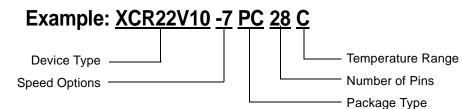
Pin Label	Description	
11-111	Dedicated input	
NC	Not Connected	
F0-F9	Macrocell Input/Output	
I0/CLK	Dedicated Input/Clock Output	
V _{CC}	Supply Voltage	
GND	Ground	

SP00474

24-pin SOIC and 24-pin TSOIC



Ordering Information



Speed Options

-10: 10 ns pin-to-pin delay -7: 7.5 ns pin-to-pin delay

Temperature Range

C = Commercial, $T_A = 0^{\circ}C$ to +70°C I = Industrial, $T_A = -40^{\circ}C$ to +85°C

Packaging Options

SO24: 24-pin SOIC VO24: 24-pin TSOIC PC28: 28-pin PLCC

Component Availability

Pins		24		28	
Туре		Plastic SOIC	Plastic Thin SOIC	Plastic PLCC	
Code		SO24	VO24	PC28	
XCR22V10	-10	C, I	C, I	C, I	
	-7	С	С	С	

Revision History

Date	Version #	Revision	
8/4/99	1.0	Initial Xilinx release.	
2/10/00	1.1	Convert to Xilinx Format	
8/10/00	1.2	Jpdated Component Availability table.	
10/09/00	1.3	Added Discontinuation Notice.	